Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/706,174	CHIEN, TIEN-CHIH	
Examiner	Art Unit	
Rick K. Chang	3729	

SEARCHED					
Class	Subclass	Date	Examiner		
29	750,751,7 53,758,26 8,33M,280	3/15/2006	RC		
72	409.06				
	409.14				
	712				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
east search	3/15/2006	RC	